

200kHz LCR-Bridge HM8118



HM8118



HZ188 4-Terminal SMD Component Test Fixture (included)



HZ184 4-Terminal Kelvin Test Cable (included)



HZ181 4-Terminal Test Fixture with Shorting Plate (optional)



- ✓ Basic Accuracy 0.05%
- ✓ Measurement Functions L, C, R, |Z|, X, |Y|, G, B, D, Q, Θ , Δ , M, N
- ✓ Test Frequencies 20Hz...200kHz
- ✓ Up to 12 Measurements per Second
- ✓ Parallel and Serial Mode
- ✓ Binning Interface H0118 (optional) for automatic Sorting of Components
- ✓ Internal programmable Voltage and Current Bias
- ✓ Transformer Parameter Measurement
- ✓ External Capacitor Bias up to 40V
- ✓ Kelvin Cable and 4-Terminal SMD Test Adapter included
- ✓ Galvanically isolated USB/RS-232 Dual-Interface, optional IEEE-488 (GPIB)

200 kHz LCR-Bridge HM8118

All data valid at 23 °C after 30 minutes warm-up.

Conditions

Test signal voltage:	1 V
Open and short corrections performed	
Measurement time:	SLOW

Display

Measurement modes:	Auto, L-Q, L-R, C-D, C-R, R-Q, Z- θ , Y- θ , R-X, G-B, N- θ , M
Equivalent circuits:	Auto, Series or Parallel
Parameters displayed:	Value, Deviation or % Deviation
Averaging:	2...99 measurements

Accuracy

Primary Parameters:	Basic accuracy (Test voltage: 1.0V, measurement SLOW/MEDIUM, autoranging mode, constant voltage OFF, bias off). For FAST mode double the basic accuracy values
---------------------	--

Impedance: 100 M Ω 4 M Ω 1 M Ω 25 k Ω 100 Ω 2.5 Ω 0.01 m Ω	0.2% + Z /1.5G Ω		0.5% + Z /100M Ω	
	0.05% + Z /2G Ω	0.1% + Z /1.5G Ω		
	0.1% + 1m Ω / Z		0.2% + 2m Ω / Z	0.5% + 5m Ω / Z + Z /10M Ω
	0.3% + 1m Ω / Z		0.5% + 2m Ω / Z	
	20 Hz	1 kHz	10 kHz	100 kHz

Secondary Parameters:

Basic accuracy D, Q:	± 0.0001 @ f = 1 kHz
Phase angle:	$\pm 0.005^\circ$ @ f = 1 kHz

Ranges

Z , R, X:	0.01 m Ω ...100 M Ω
Y , G, B:	10 nS...1,000 S
C:	0.01 pF...100 mF
L:	10 nH...100 kH
D:	0.0001...9.9999
Q:	0.1...9,999.9
θ :	-180...+180 $^\circ$
Δ :	-999.99...999.99%
M:	1 μ H...100 H
N:	0.95...500

Measurement conditions and functions

Test frequency:	20 Hz...200 kHz (69 steps)
Frequency accuracy:	± 100 ppm
AC test signal level:	50 mV _{rms} ...1.5 V _{rms}
Resolution	10 mV _{rms}
Drive level accuracy:	$\pm(5\% + 5$ mV)
Internal Bias Voltage:	0...+5.00 V _{dc}
Resolution	10 mV
External Bias Voltage:	0...+40 V _{dc} (fused 0.5 A)
Internal Bias Current:	0...+200 mA
Resolution	1 mA
Range Selection:	Auto and Hold
Trigger:	Continuous, manual or external via interface, Binning Interface or Trigger Input
Trigger delay time:	0...999 ms in 1 ms steps
Measurement time (f ≥ 1 kHz):	
FAST	70 ms
MEDIUM	125 ms
SLOW	0.7 s

Other Instrument Functions

Test signal level monitor:	Voltage, current
Error Correction:	Open, Short, Load
Save/Recall:	9 instrument settings
Front-end Protection:	V _{max} < $\sqrt{2}C$ @ V _{max} < 200V, C in Farads (1 Joule of stored energy)

Low Potential and Low Current Guarding: Ground, Driven Guard or Auto (fused)

Constant Voltage Mode (25 Ω source):

Temperature effects R, L or C ± 5 ppm/ $^\circ$ C

Interface: Dual-Interface USB/RS-232 (H0820), IEEE-488 (GPIB) (optional)

Safety Class: Safety Class I (EN61010-1)

Power supply: 110...230V $\pm 10\%$, 50...60Hz, CAT II

Power consumption: approx. 20W

Operating temperature: +5...+40 $^\circ$ C

Storage temperature: -20...+70 $^\circ$ C

Rel. humidity: 5...80% (non condensing)

Dimensions (W x H x D): 285 x 75 x 365 mm

Weight: approx. 4 kg

Accessories supplied: Line cord, Operating manual, HZ184 4 Terminal Kelvin Test Cable and HZ188 4 Terminal SMD Component Test Fixture, CD

Recommended accessories:

H0118	Binning Interface
H0880	Interface IEEE-488 (GPIB), galvanically isolated
HZ13	Interface cable (USB) 1.8m
HZ14	Interface cable (serial) 1:1
HZ33	Test cable 50 Ω , BNC/BNC, 0.5m
HZ34	Test cable 50 Ω , BNC/BNC, 1.0m
HZ42	19" Rackmount kit 2RU
HZ72	GPIB-Cable 2m
HZ181	4 Terminal Test Fixture including Shorting Plate
HZ186	4 Terminal Transformer Test Cable